

**Search Notes**

Application/Control No.

10/731,610

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under  
Reexamination

KWON ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	254	8/2/2005	NKV
330	257	8/2/2005	NKV
330	261	8/2/2005	NKV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See Search History Printout		1/18/2006	NKV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	1/18/2006	NKV